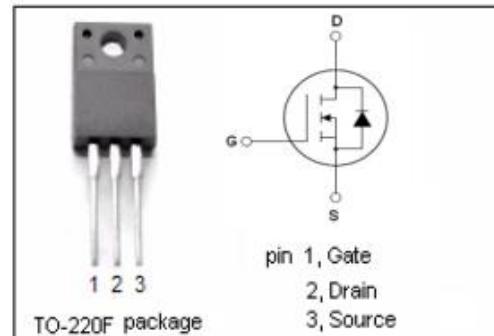


## iscN-Channel MOSFET Transistor

**TK18A50D, ITK18A50D**

### • FEATURES

- Low drain-source on-resistance:  
 $R_{DS(on)} = 0.22\Omega$  (typ.)
- Enhancement mode:  
 $V_{TH} = 2.0$  to  $4.0V$  ( $V_{DS} = 10 V$ ,  $I_D=1.0mA$ )
- 100% avalanche tested
- Minimum Lot-to-Lot variations for robust device performance and reliable operation

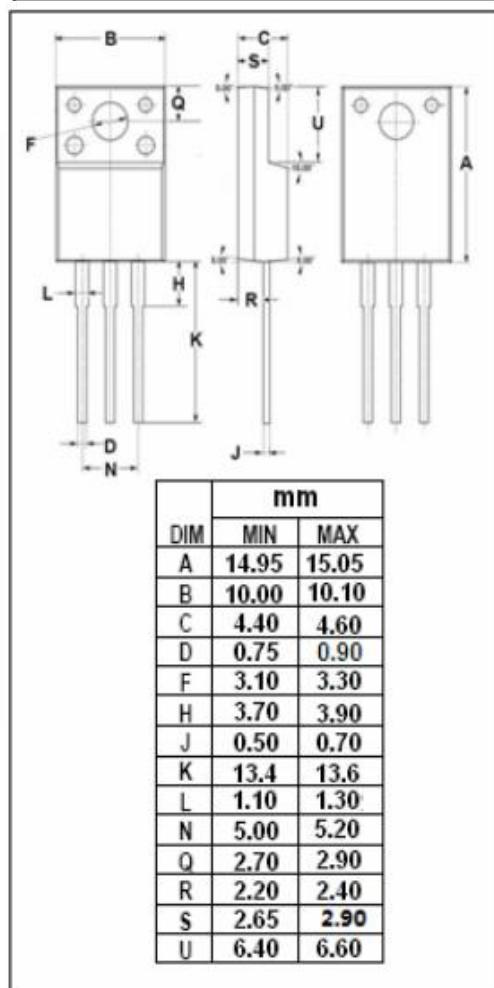


### • DESCRIPTION

- Switching Voltage Regulators

### • ABSOLUTE MAXIMUM RATINGS( $T_a=25^\circ C$ )

SYMBOL	PARAMETER	VALUE	UNIT
$V_{DSS}$	Drain-Source Voltage	500	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Drain Current-Continuous	18	A
$I_{DM}$	Drain Current-Single Pulsed	72	A
$P_D$	Total Dissipation @ $T_c=25^\circ C$	50	W
$T_j$	Max. Operating Junction Temperature	150	$^\circ C$
$T_{stg}$	Storage Temperature	-55~150	$^\circ C$



### • THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	MAX	UNIT
$R_{th(ch-c)}$	Channel-to-case thermal resistance	2.5	$^\circ C/W$
$R_{th(ch-a)}$	Channel-to-ambient thermal resistance	62.5	$^\circ C/W$

**iscN-Channel MOSFET Transistor****TK18A50D, ITK18A50D****ELECTRICAL CHARACTERISTICS** $T_c=25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}; \text{I}_D= 10\text{mA}$	500			V
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}= 10\text{V}; \text{I}_D=1.0\text{mA}$	2.0		4.0	V
$\text{R}_{\text{DS(on)}}$	Drain-Source On-Resistance	$\text{V}_{\text{GS}}=10\text{V}; \text{I}_D=9\text{A}$		220	270	$\text{m}\Omega$
$\text{I}_{\text{GSS}}$	Gate-Source Leakage Current	$\text{V}_{\text{GS}}= \pm 30\text{V}; \text{V}_{\text{DS}}= 0\text{V}$			$\pm 1$	$\mu\text{A}$
$\text{I}_{\text{DSS}}$	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=500\text{V}; \text{V}_{\text{GS}}= 0\text{V}$			10	$\mu\text{A}$
$\text{V}_{\text{SDF}}$	Diode forward voltage	$\text{I}_{\text{DR}} = 18\text{A}, \text{V}_{\text{GS}} = 0 \text{ V}$			1.7	V